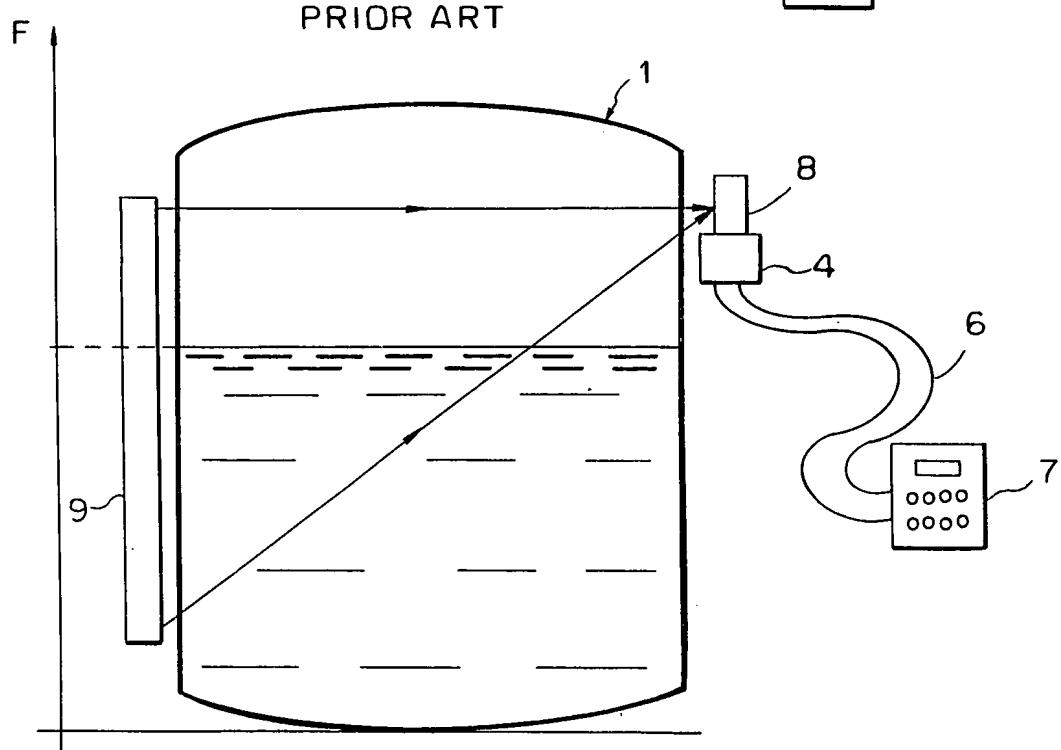
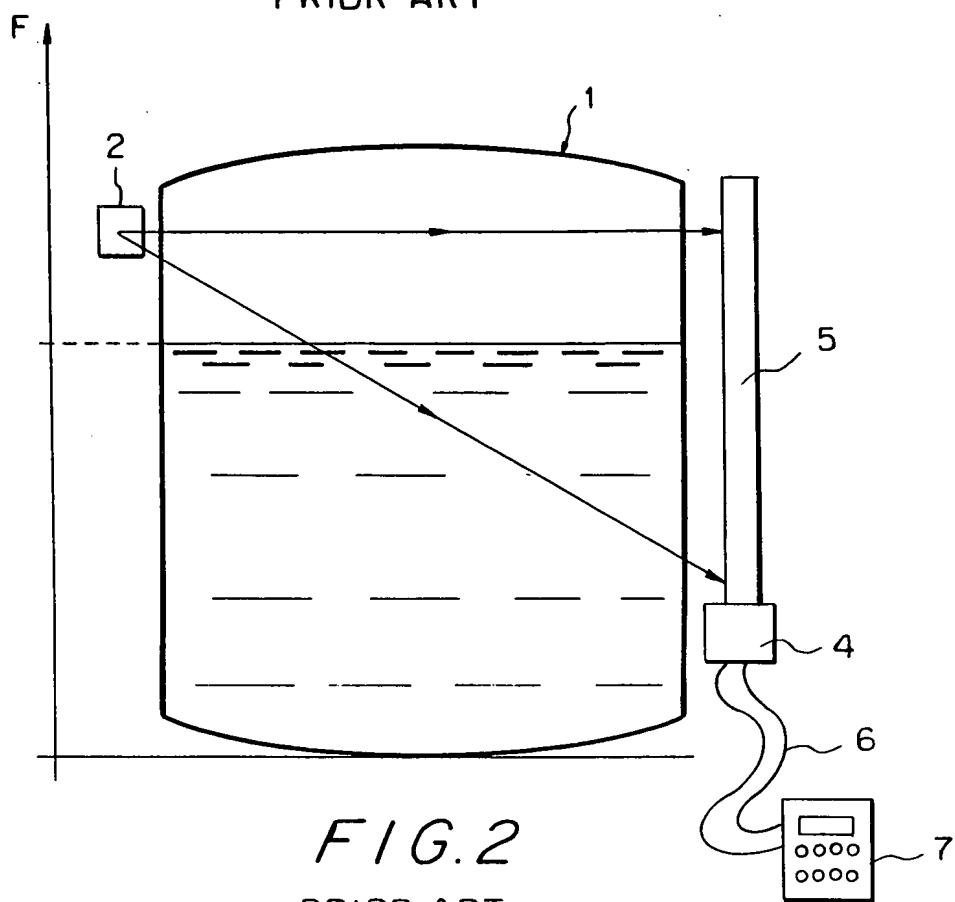


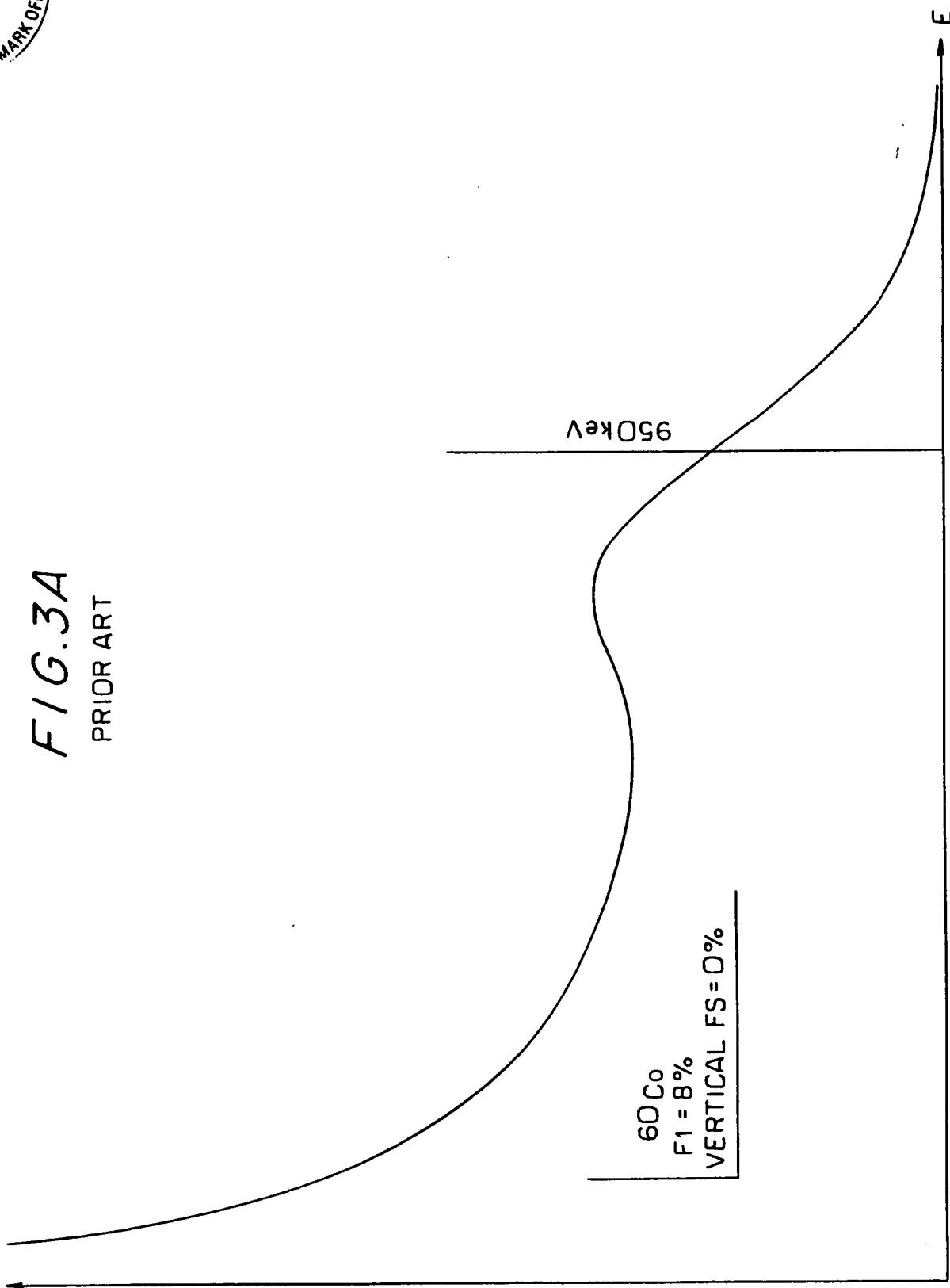


FIG. 1
PRIOR ART





F/G.3A
PRIOR ART





F/G.3B
PRIOR ART

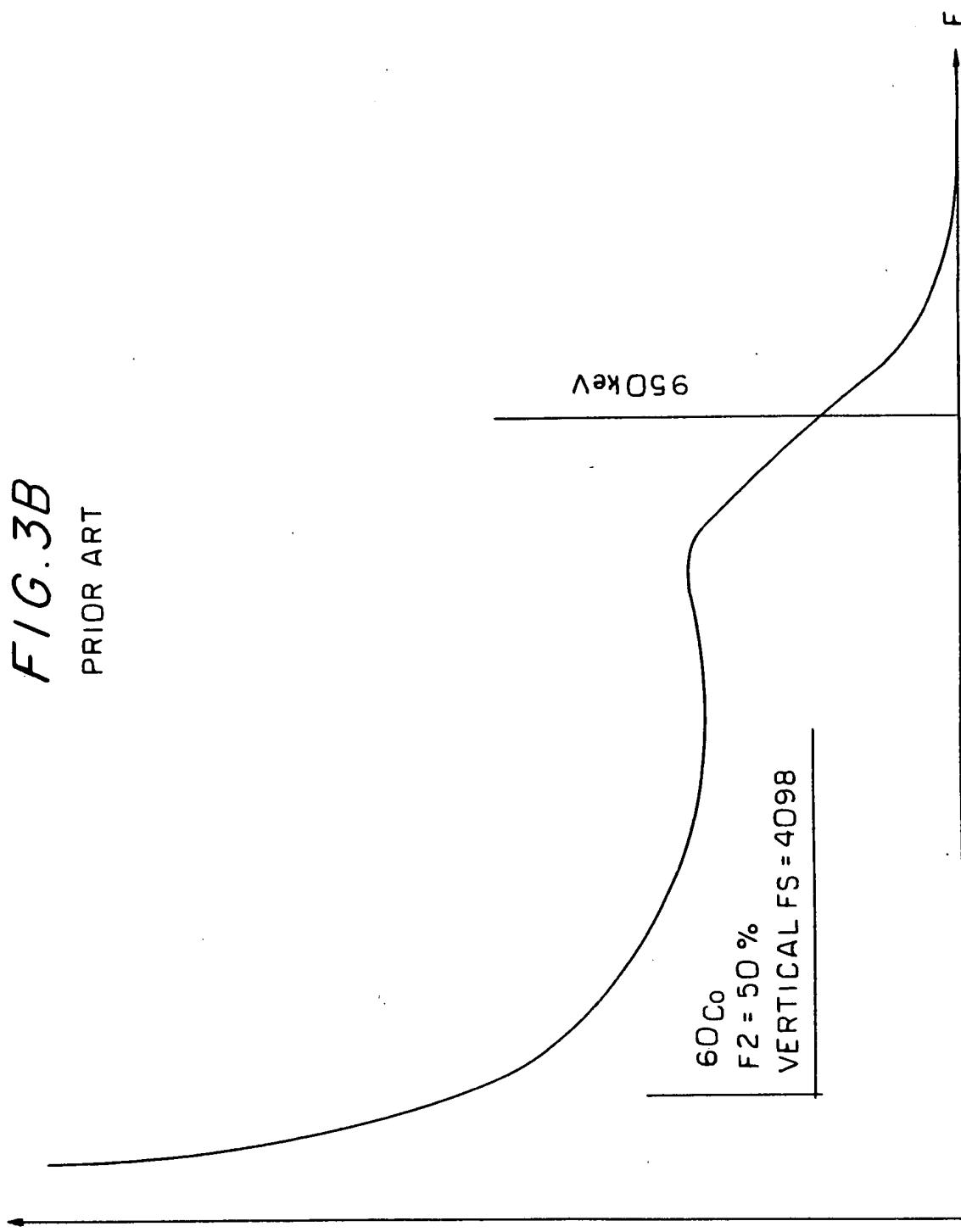




FIG. 3C
PRIOR ART

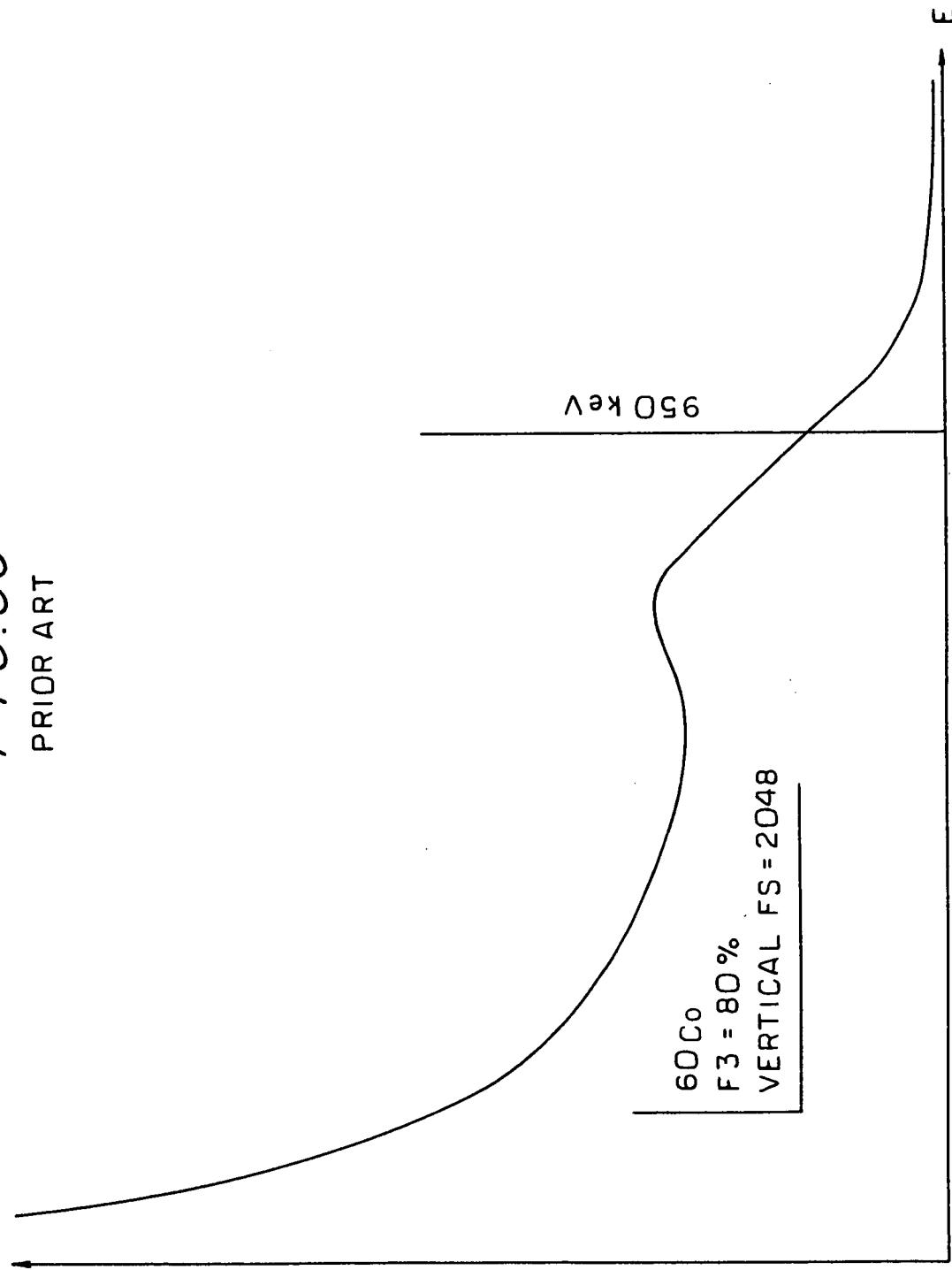




FIG. 3D
PRIOR ART

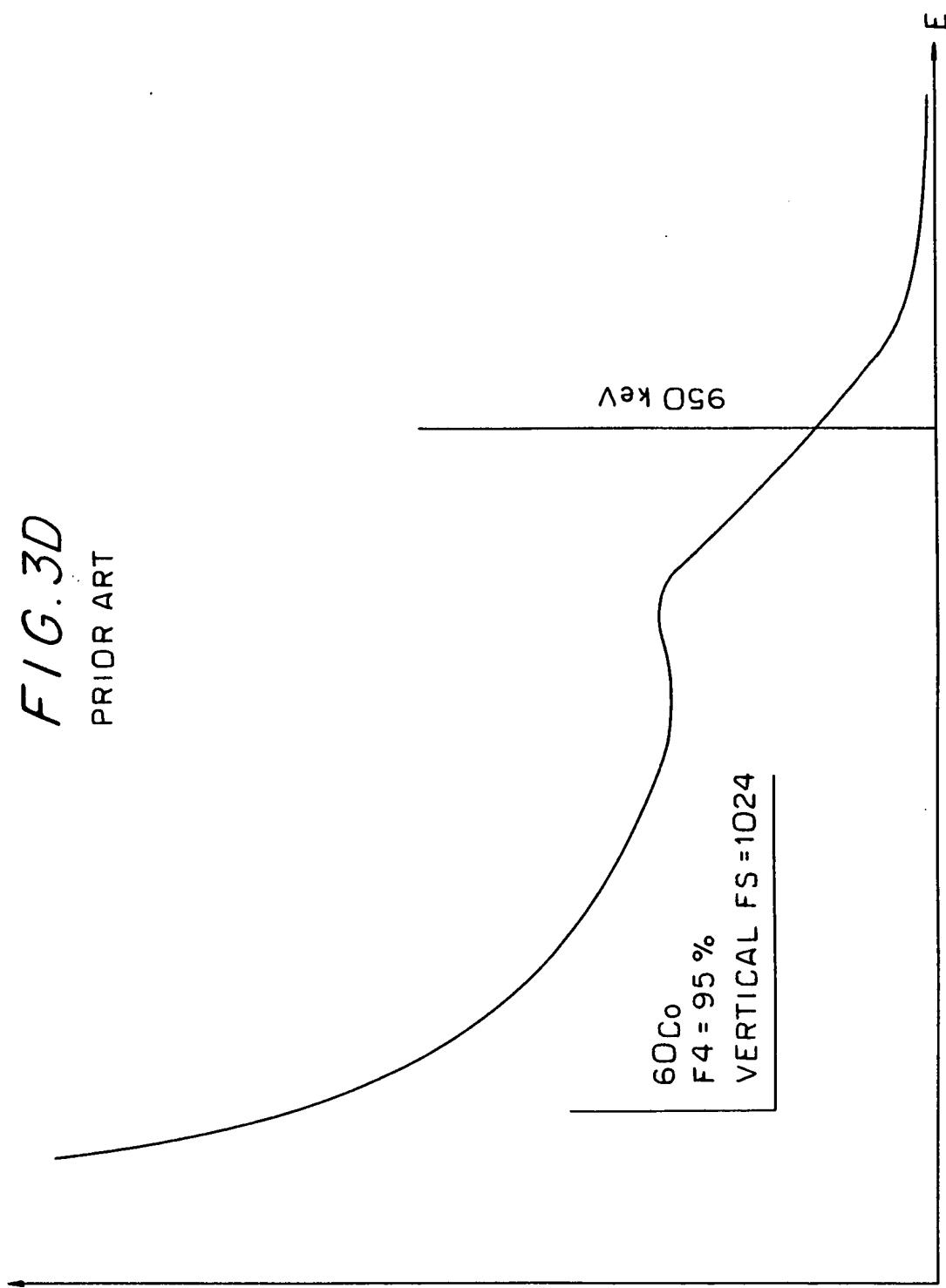




FIG. 3E
PRIOR ART

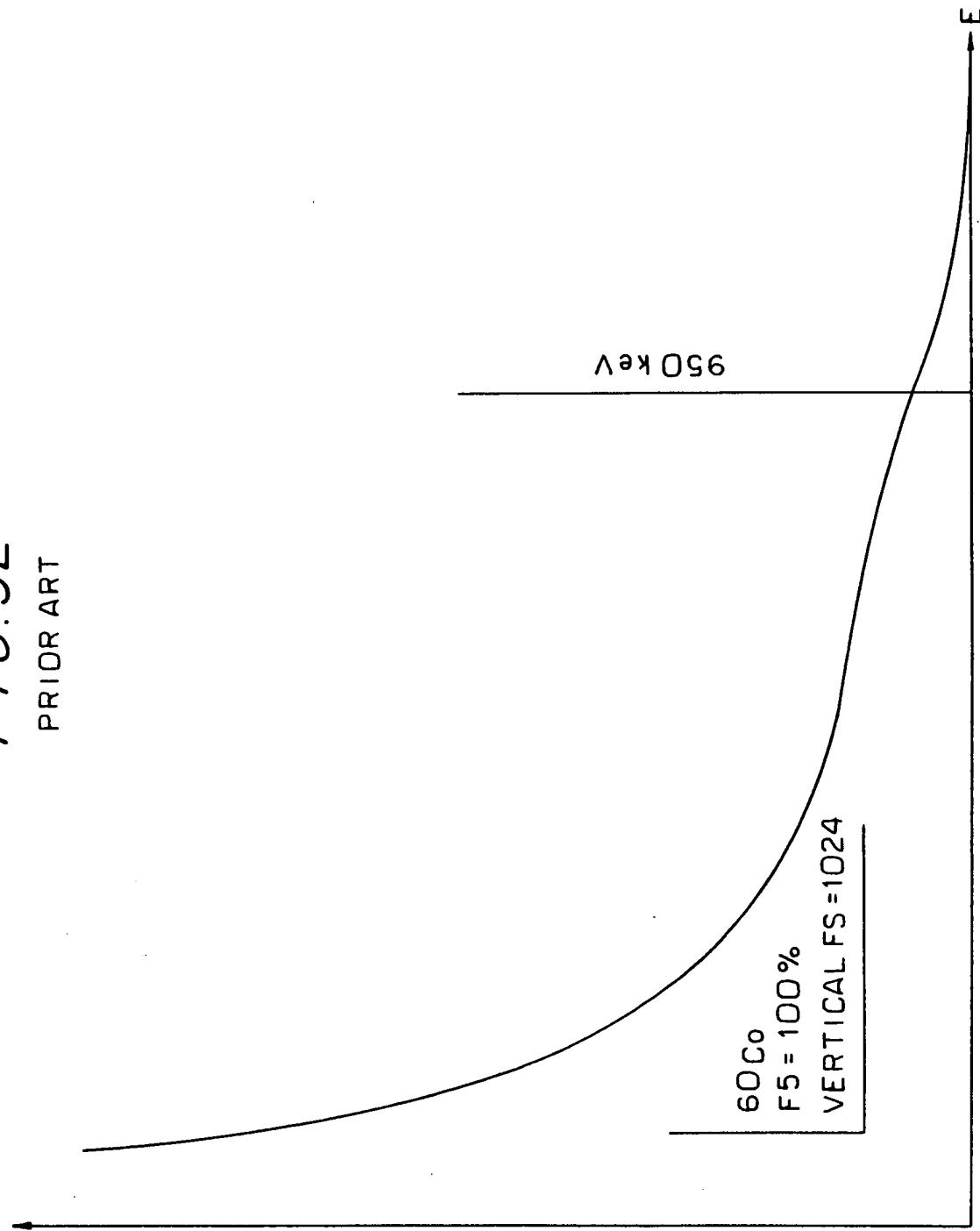
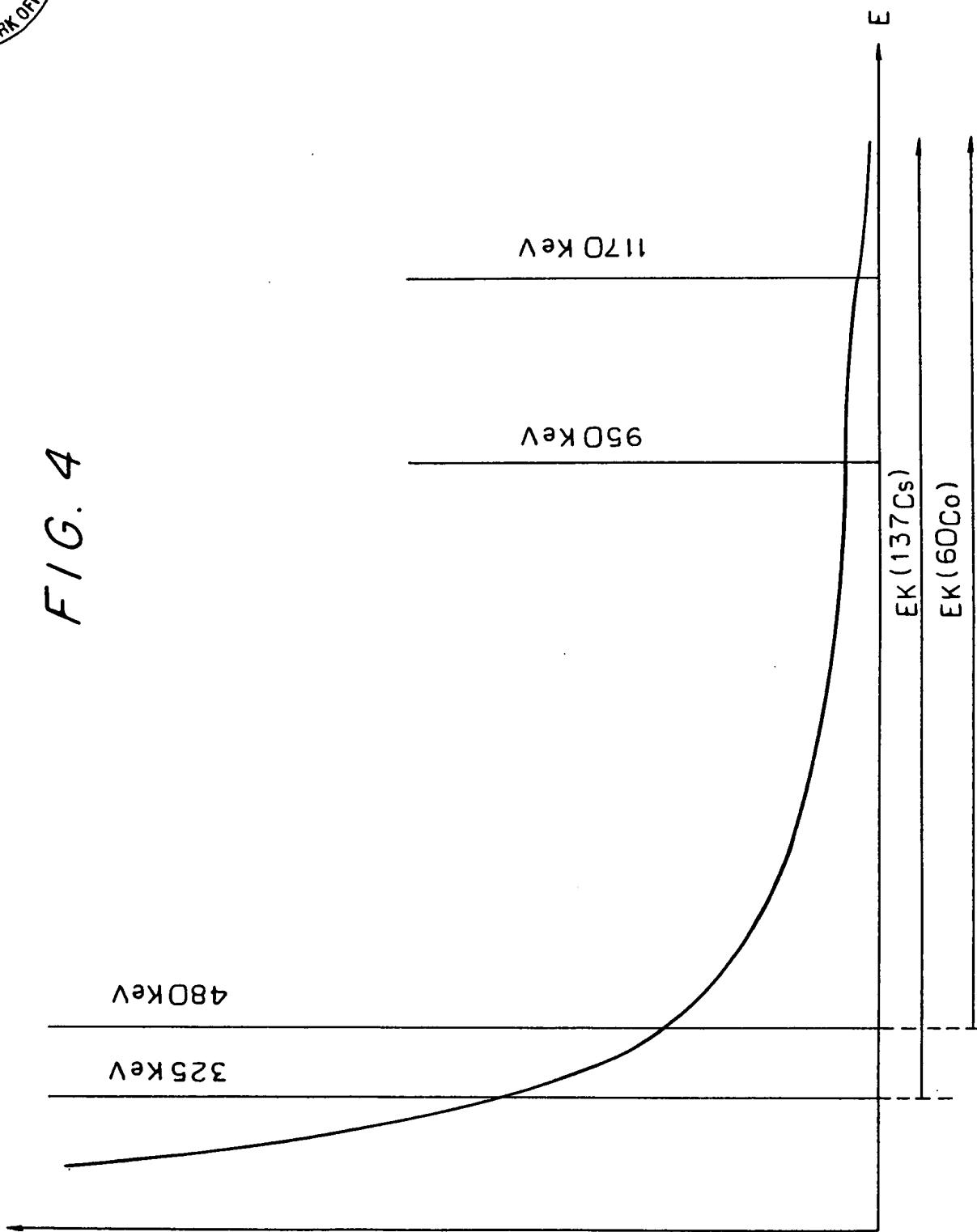




FIG. 4



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FIG. 5

CALIBRATION CURVES FOR THE MEASUREMENT CHANNEL AND
SUBSTITUTE CHANNEL (MEASUREMENT RANGE = 200cm)

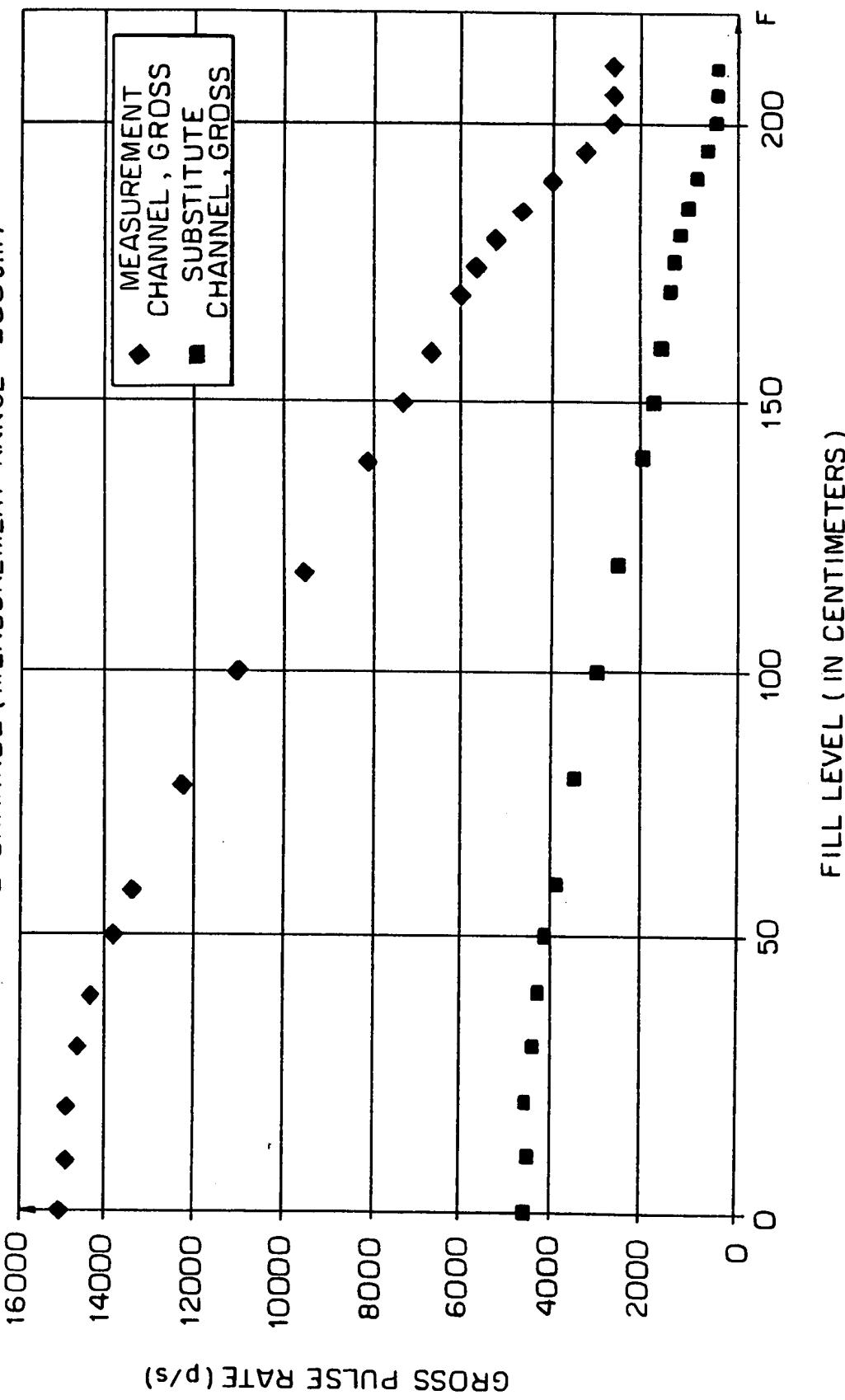




FIG. 6

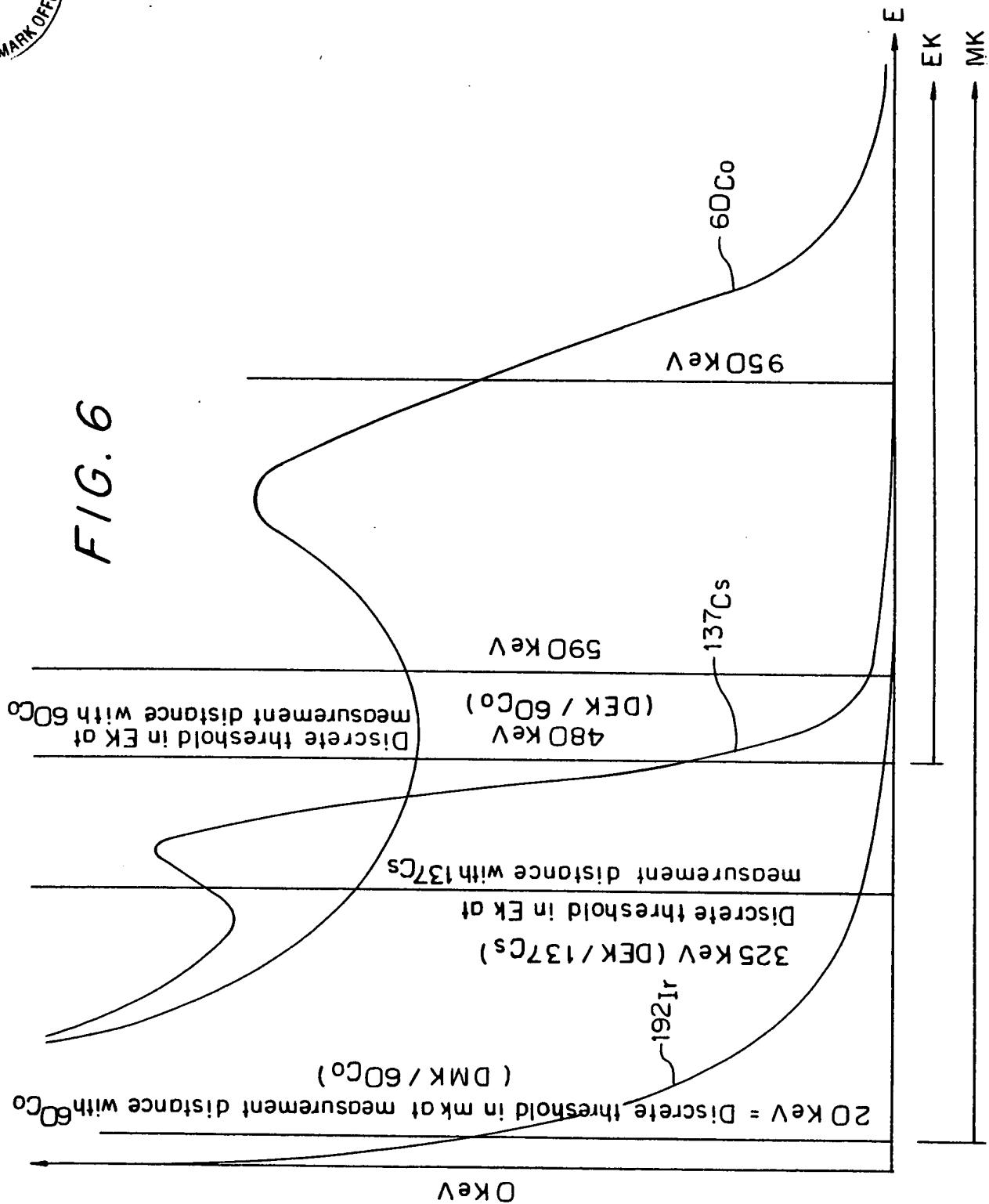




FIG. 7

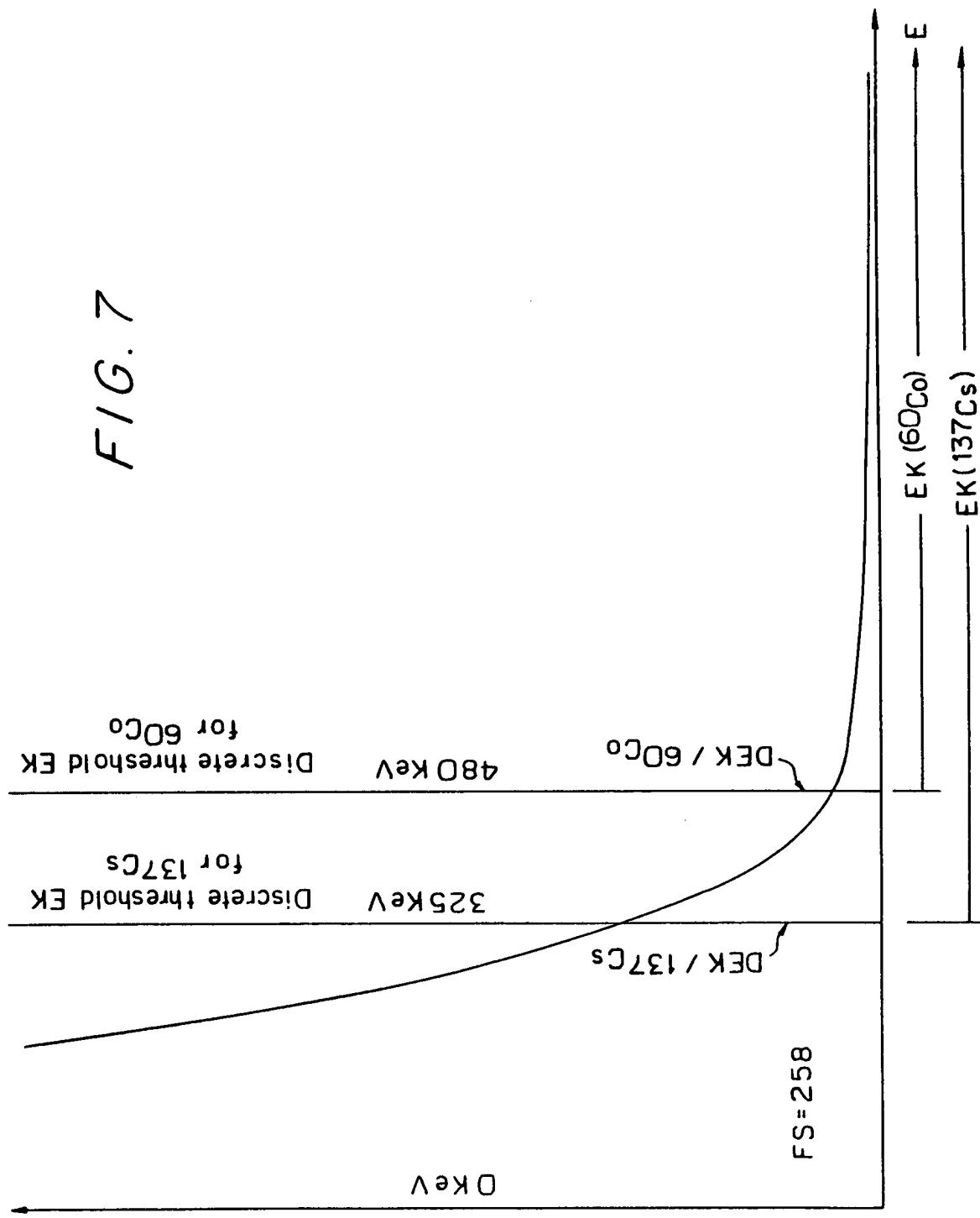


FIG. 8

Co-60 PLATEAU IN MEASUREMENT CHANNEL (MK)

The discriminator threshold in the measurement channel is
20 KeV at operating point = 950V

COUNTING RATE, IN CPS

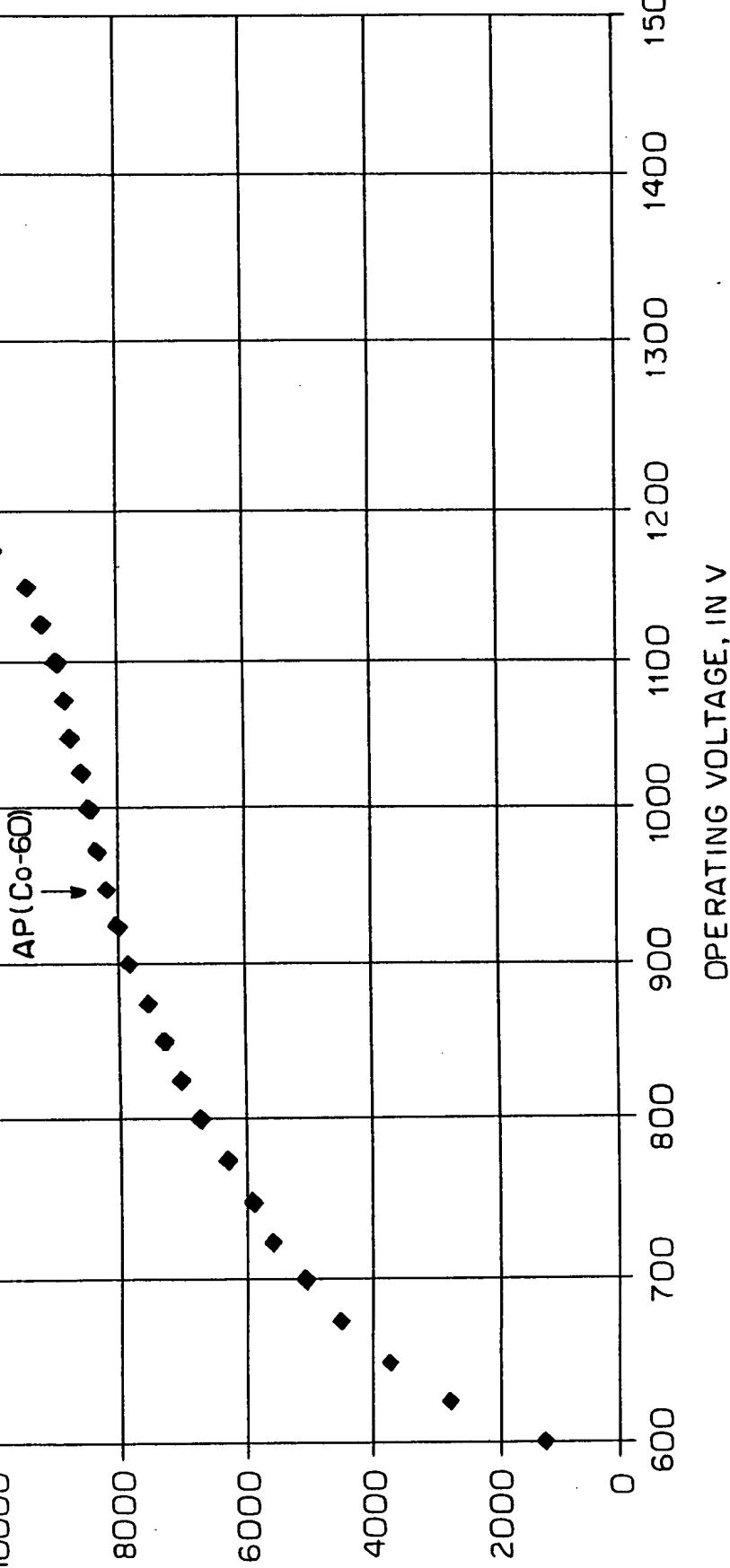
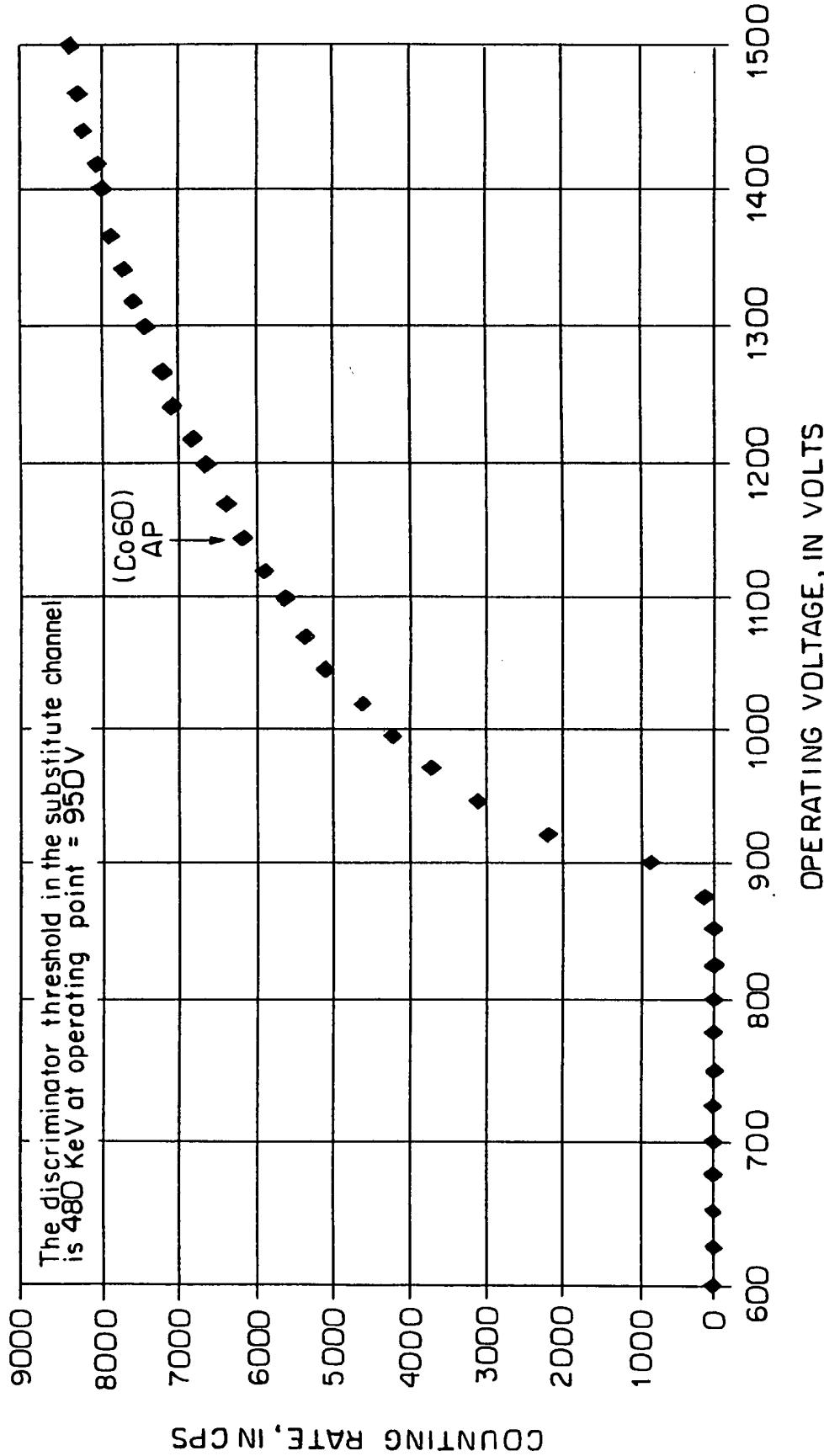


FIG. 9

Co-60 PLATEAU IN SUBSTITUTE CHANNEL (EK)



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FIG. 10

Cs- 137 PLATEAU IN MEASUREMENT CHANNEL (MK)

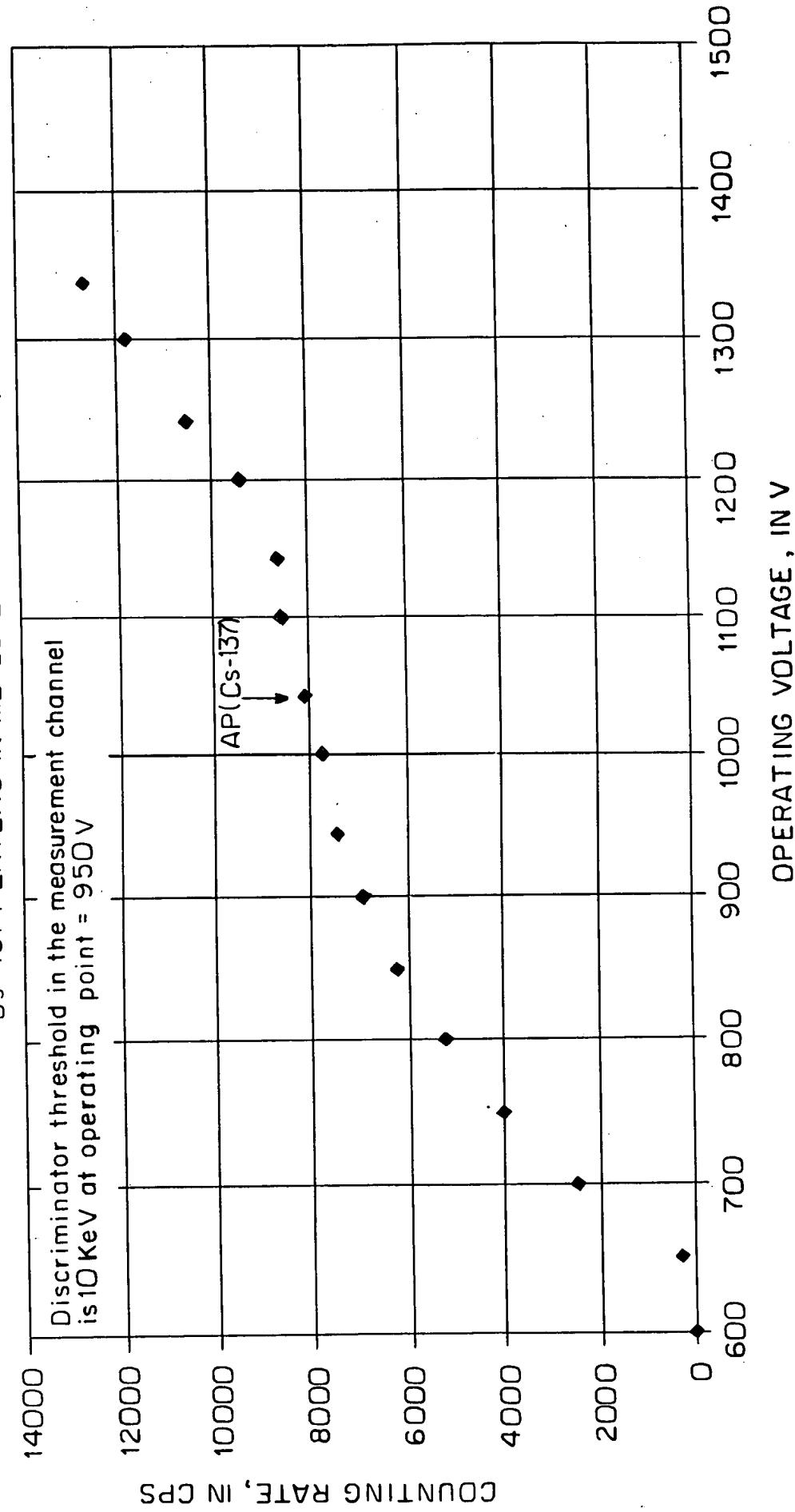


FIG. 11

Cs - 137 PLATEAU IN SUBSTITUTE CHANNEL(EK)

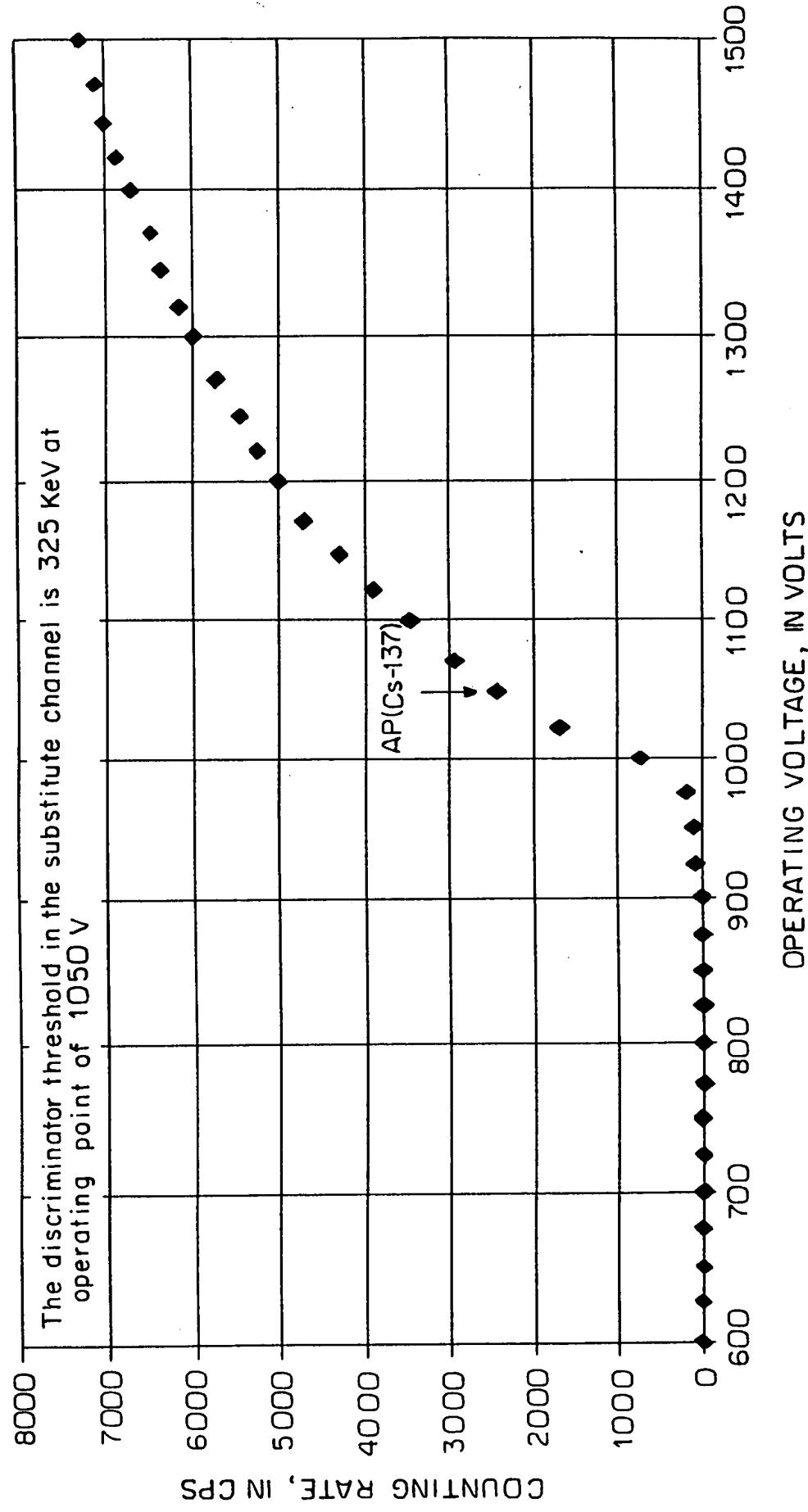
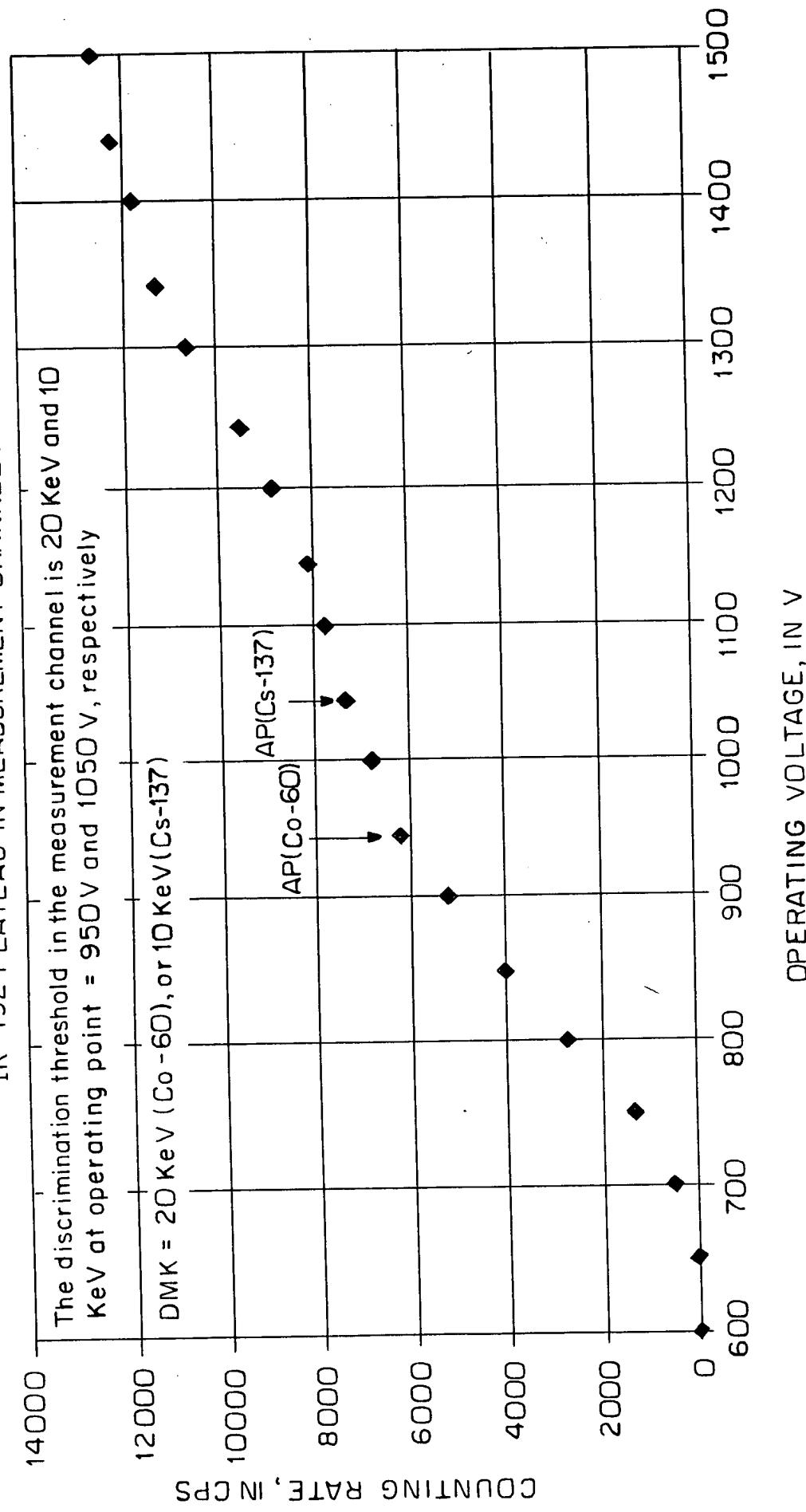


FIG. 12

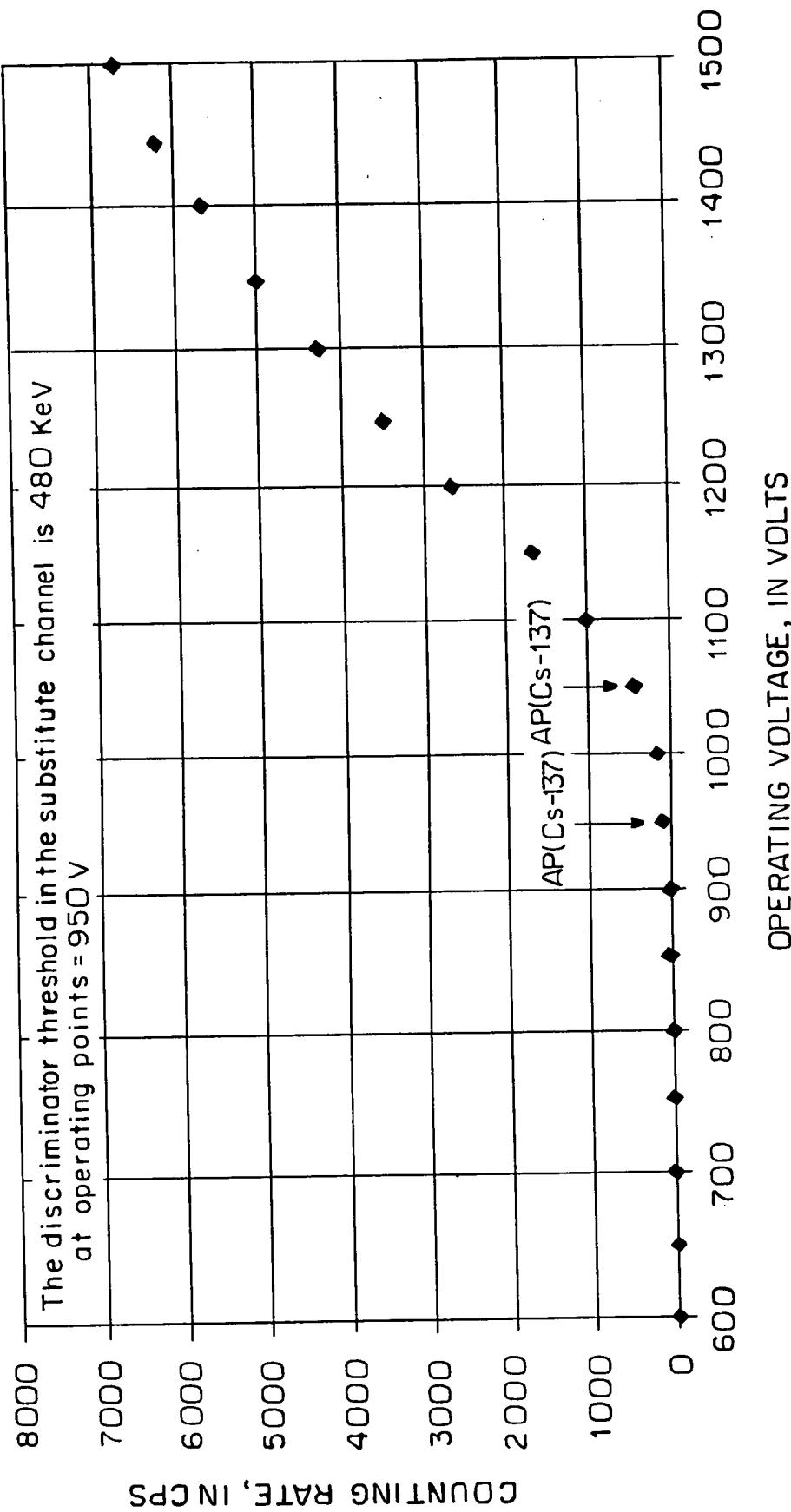
IR -192 PLATEAU IN MEASUREMENT CHANNEL (MK)



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FIG. 13

Ir-192 PLATEAU IN SUBSTITUTE CHANNEL (EK)



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FIG. 14

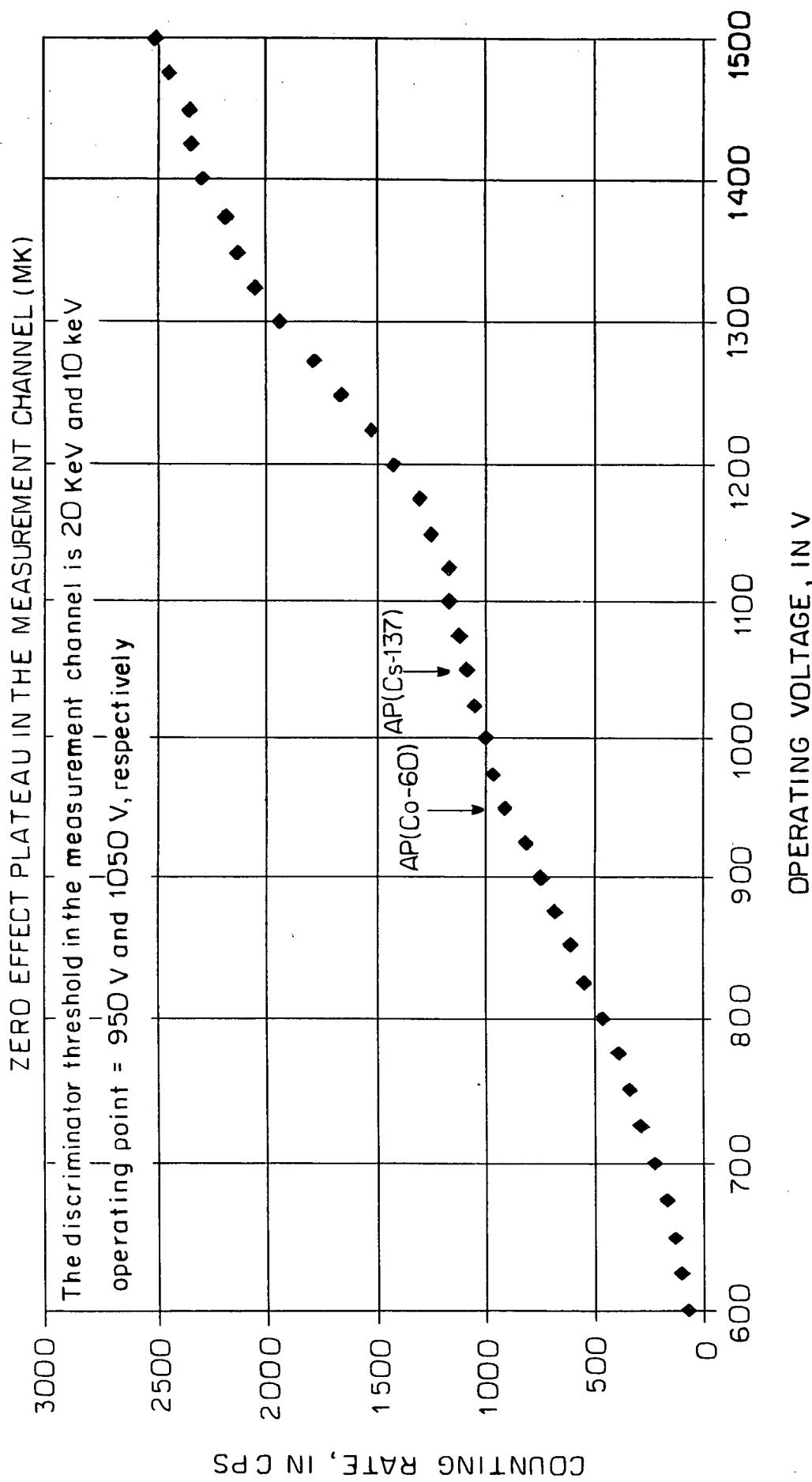
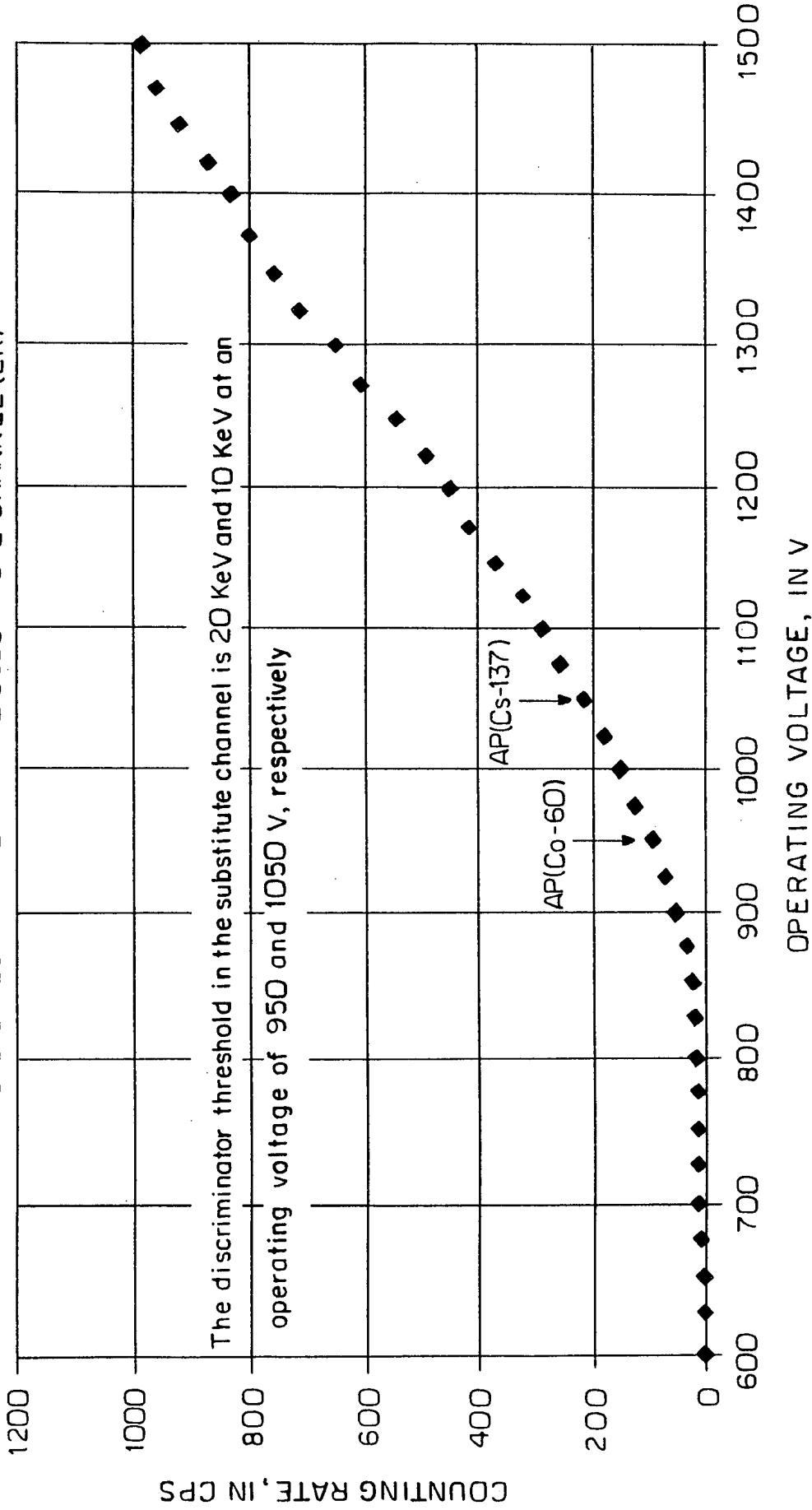
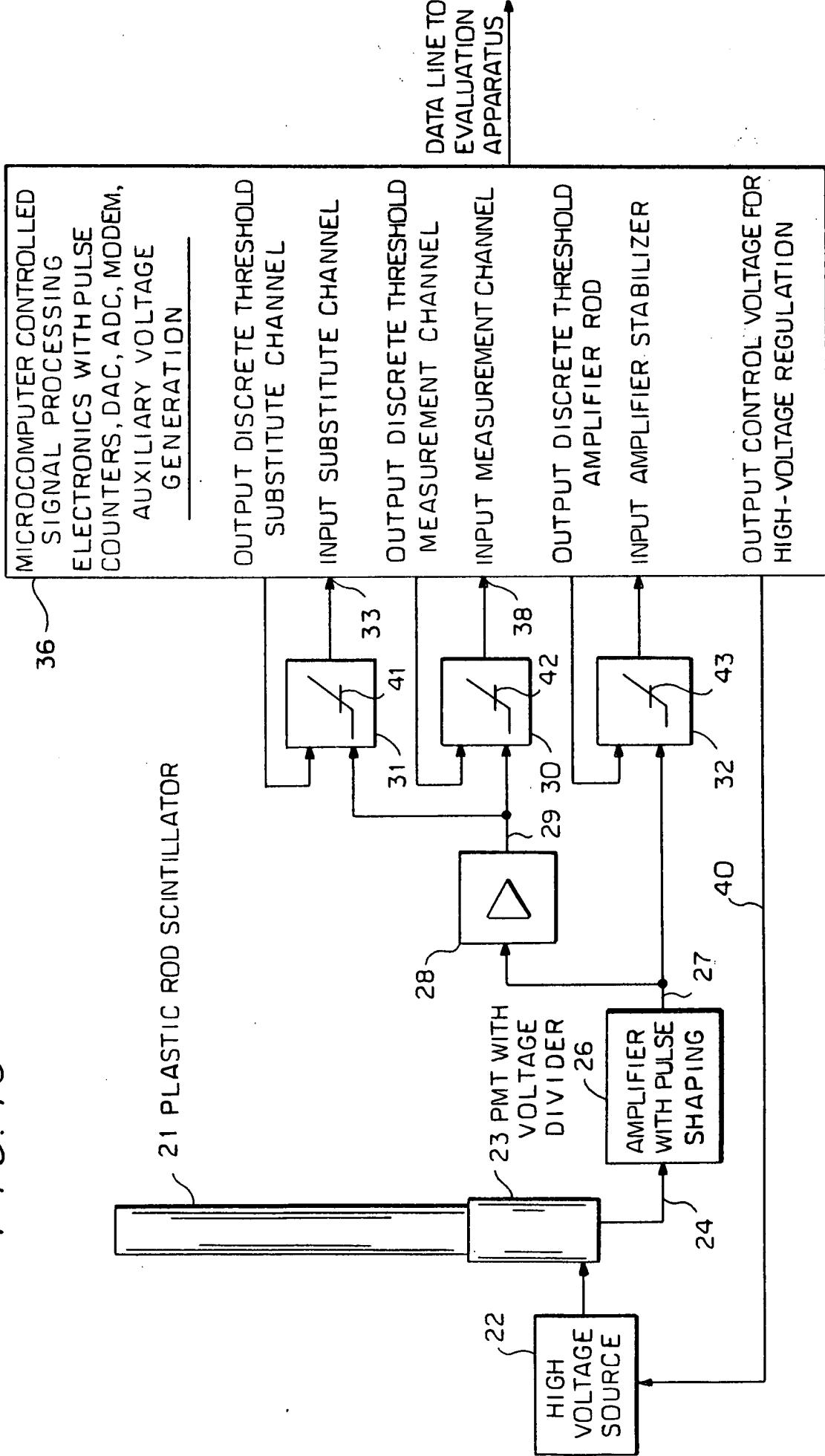


FIG. 15

ZERO EFFECT PLATEAU IN THE SUBSTITUTE CHANNEL (EK)



F/G. 16



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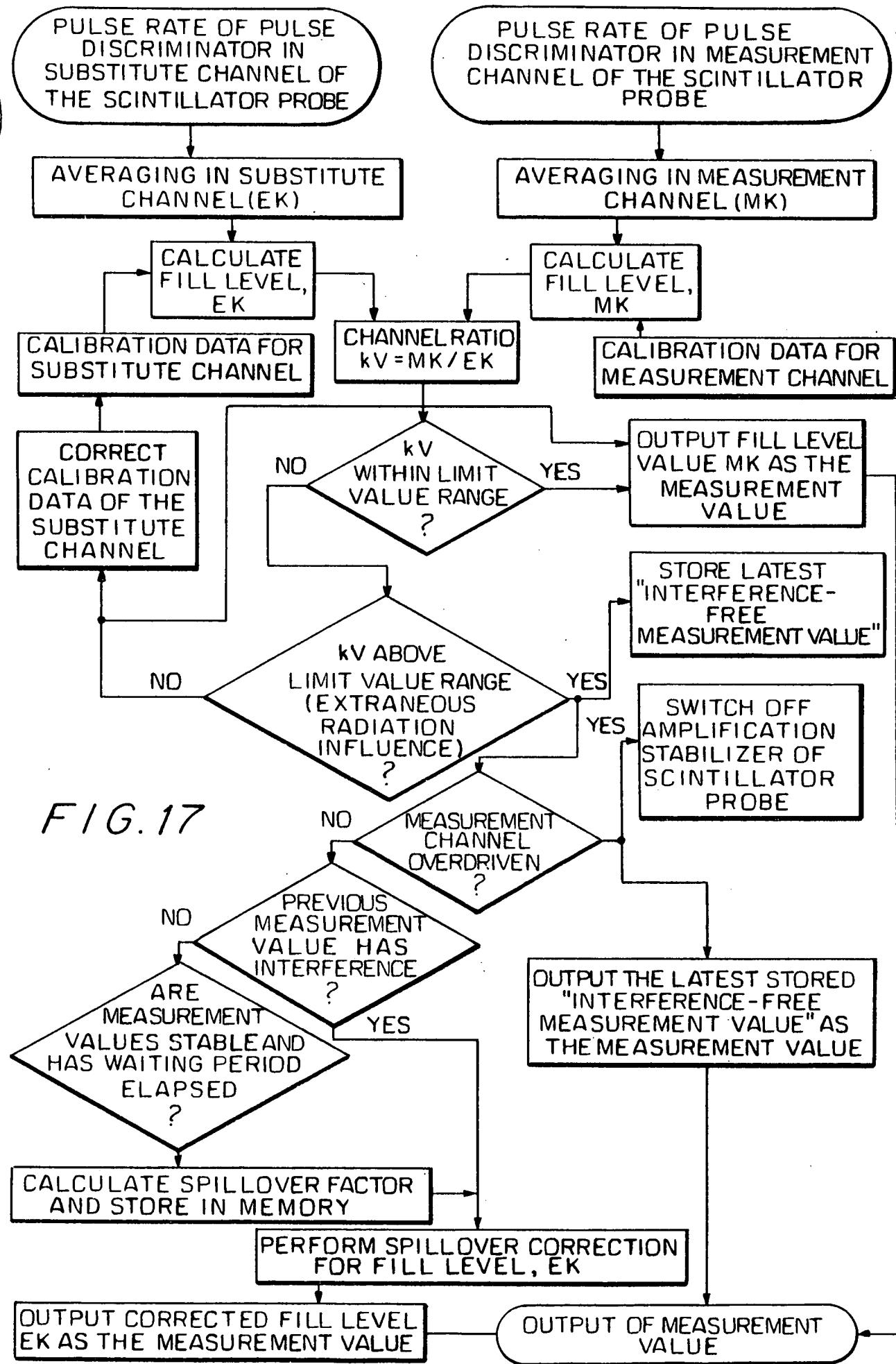


FIG. 18

